

MOSFET – P-Channel, POWERTRENCH®

-30 V, -20 A, 10 m Ω

FDMC6679AZ

General Description

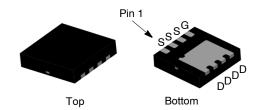
The FDMC6679AZ has been designed to minimize losses in load switch applications. Advancements in both silicon and package technologies have been combined to offer the lowest $r_{DS(on)}$ and ESD protection.

Features

- Max $r_{DS(on)} = 10 \text{ m}\Omega$ at $V_{GS} = -10 \text{ V}$, $I_D = -11.5 \text{ A}$
- Max $r_{DS(on)} = 18 \text{ m}\Omega$ at $V_{GS} = -4.5 \text{ V}$, $I_D = -8.5 \text{ A}$
- HBM ESD Protection Level of 8 kV Typical (Note 3)
- Extended V_{GSS} range (-25 V) for Battery Applications
- High Performance Trench Technology for Extremely Low r_{DS(on)}
- High Power and Current Handling Capability
- This Device is Pb-Free and Halide Free

Applications

- Load Switch in Notebook and Server
- Notebook Battery Pack Power Management



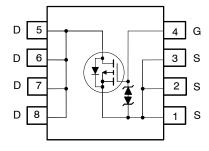
WDFN8 3.3x3.3, 0.65P CASE 511DH

MARKING DIAGRAM

FDMC 6679AZ ALYW

FDMC6679AZ = Specific Device Code
A = Assembly Location
L = Wafer Lot Number
YW = Assembly Start Week

PIN ASSIGNMENT



ORDERING INFORMATION

See detailed ordering and shipping information on page 6 of this data sheet.

MOSFET MAXIMUM RATINGS ($T_A = 25^{\circ}C$ unless otherwise noted)

| Symbol | Parameter | | | Rating | Unit |
|-----------------------------------|---|----------------------|-----------------------|--------------|------|
| V _{DS} | Drain to Source Voltage | | | -30 | V |
| V _{GS} | Gate to Source Voltage | | | ±25 | V |
| I _D | Drain Current | Continuous | T _C = 25°C | -20 | Α |
| | | Continuous (Note 1a) | T _A = 25°C | -11.5 | |
| | | Pulsed | | -32 | |
| P_{D} | Power Dissipation $T_C = 25^{\circ}C$ | | T _C = 25°C | 41 | W |
| | Power Dissipation (Note 1a) T _A = 25°C | | | 2.3 | |
| T _J , T _{STG} | Operating and Storage Junction Temperature Range | | | -55 to + 150 | °C |

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL CHARACTERISTICS

| Symbol | Parameter | Ratings | Unit |
|-----------------|---|---------|------|
| $R_{	heta JC}$ | Thermal Resistance, Junction to Case | 3.0 | °C/W |
| $R_{\theta JA}$ | Thermal Resistance, Junction to Ambient (Note 1a) | 53 | |

1. $R_{\theta JA}$ is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.



a. 53°C/W when mounted on a 1 in² pad of 2 oz copper



b. 125°C/W when mounted on a minimum pad of 2 oz copper

- 2. Pulse Test: Pulse Width < 300 μ s, Duty cycle < 2.0%.
- 3. The diode connected between the gate and source serves only as protection against ESD. No gate overvoltage rating is implied.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted)

| Symbol | Parameter | Test Conditions | Min | Тур | Max | Unit |
|--|---|--|------|------|------|-------|
| OFF CHARA | CTERISTICS | | • | | - | |
| BV _{DSS} | Drain to Source Breakdown Voltage | $I_D = -250 \ \mu A, \ V_{GS} = 0 \ V$ | -30 | | | V |
| $\frac{\Delta BV_{DSS}}{\Delta T_{J}}$ | Breakdown Voltage Temperature Coefficient | I_D = -250 μ A, Referenced to 25°C | | 29 | | mV/°C |
| I _{DSS} | Zero Gate Voltage Drain Current | V _{DS} = -24 V, V _{GS} = 0 V | | | -1 | μΑ |
| | | V _{DS} = -24 V, V _{GS} = 0 V, T _J = 125°C | | | -100 | 1 |
| I _{GSS} | Gate to Source Leakage Current | V _{GS} = ±25 V, V _{DS} = 0 V | | | ±10 | μΑ |
| ON CHARAC | CTERISTICS | | - | | - | |
| V _{GS(th)} | Gate to Source Threshold Voltage | $V_{GS} = V_{DS}, I_D = -250 \mu A$ | -1.0 | -1.8 | -3 | V |
| $\frac{\Delta V_{GS(th)}}{\Delta T_{J}}$ | Gate to Source Threshold Voltage Temperature Coefficient | I _D = -250 μA, Referenced to 25°C | | -7 | | mV/°C |
| r _{DS(on)} | Static Drain | V _{GS} = -10 V, I _D = -11.5 A | | 8.6 | 10 | mΩ |
| | to Source On Resistance | V _{GS} = -4.5 V, I _D = -8.5 A | | 12 | 18 | |
| | | V _{GS} = -10 V, I _D = -11.5 A, T _J = 125°C | | 12 | 15 | |
| 9FS | Forward Transconductance | V _{DS} = -5 V, I _D = -11.5 A | | 46 | | S |
| OYNAMIC C | HARACTERISTICS | | | L | | |
| C _{iss} | Input Capacitance | V _{DS} = -15 V, V _{GS} = 0 V, f = 1 MHz | | 2985 | 3970 | pF |
| C _{oss} | Output Capacitance | | | 570 | 755 | pF |
| C _{rss} | Reverse Transfer Capacitance | | | 500 | 750 | pF |
| SWITCHING | CHARACTERISTICS | | | • | | • |
| t _{d(on)} | Turn-On Delay Time | $V_{DD} = -15 \text{ V}, I_D = -11.5 \text{ A}, V_{GS} = -10 \text{ V},$ | | 12 | 21 | ns |
| t _r | Rise Time | $R_{GEN} = 6 \Omega$ | | 14 | 25 | ns |
| t _{d(off)} | Turn-Off Delay Time | | | 63 | 100 | ns |
| t _f | Fall Time | | | 46 | 73 | ns |
| Qg | Total Gate Charge | V_{GS} = 0 V to -10 V, V_{DD} = -15 V, I_D = -11.5 A | | 65 | 91 | nC |
| | | $V_{GS} = 0 \text{ V to } -5 \text{ V}, V_{DD} = -15 \text{ V}, I_D = -11.5 \text{ A}$ | | 37 | 52 | nC |
| Q _{gs} | Gate to Source Charge | $V_{DD} = -15 \text{ V}, I_D = -11.5 \text{ A}$ | | 8.7 | | nC |
| Q _{gd} | Gate to Drain "Miller" Charge | | | 17 | | nC |
| DRAIN-SOU | IRCE DIODE CHARACTERISTICS | | | | | |
| V _{SD} | Source to Drain Diode Forward Voltage | V _{GS} = 0 V, I _S = -11.5 A (Note 2) | | 0.83 | 1.30 | V |
| | | V _{GS} = 0 V, I _S = -1.6 A (Note 2) | | 0.71 | 1.20 | 1 |
| t _{rr} | Reverse Recovery Time | I _F = -11.5 A, di/dt = 100 A/μs | | 31 | 49 | ns |
| Q _{rr} | Reverse Recovery Charge | | | 16 | 28 | nC |
| Q _{rr} | neverse necovery Charge | | | 16 | 28 | |

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

TYPICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

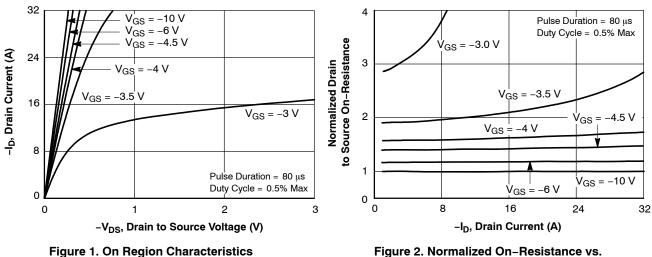


Figure 1. On Region Characteristics

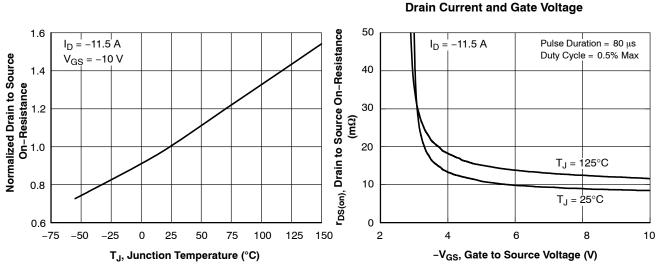


Figure 3. Normalized On Resistance vs. Junction Temperature

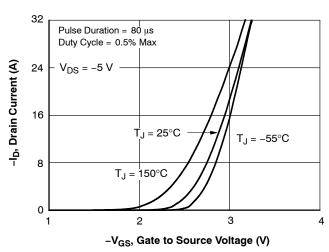


Figure 5. Transfer Characteristics

Figure 4. On-Resistance vs. Gate to Source Voltage

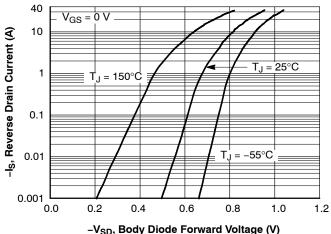


Figure 6. Source to Drain Diode Forward Voltage vs. Source Current

TYPICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted) (continued)

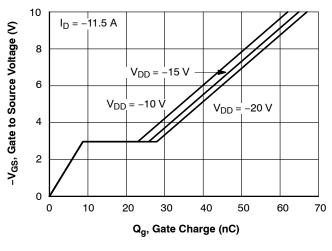
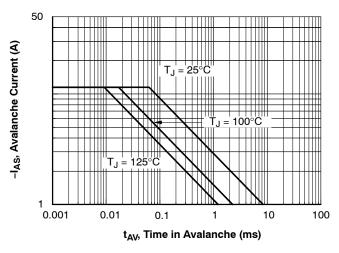


Figure 7. Gate Charge Characteristics

Figure 8. Capacitance vs. Drain to Source Voltage



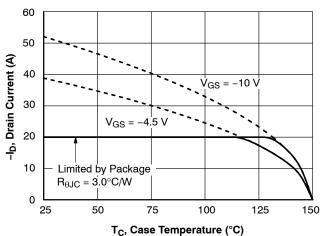
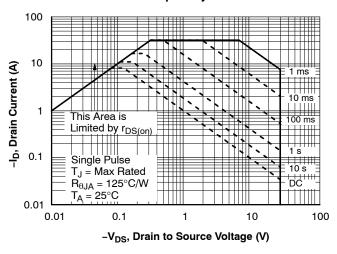


Figure 9. Unclamped Inductive Switching Capability

Figure 10. Maximum Continuous Drain Current vs Case Temperature



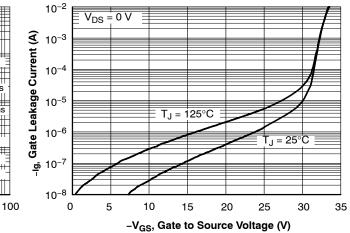


Figure 11. Forward Bias Safe Operating Area

Figure 12. Igss vs. Vgss

TYPICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted) (continued)



Figure 13. Single Pulse Maximum Power Dissipation

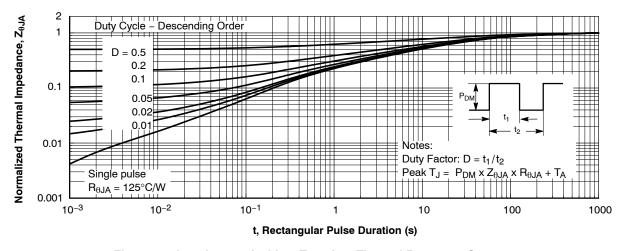


Figure 14. Junction-to-Ambient Transient Thermal Response Curve

ORDERING INFORMATION

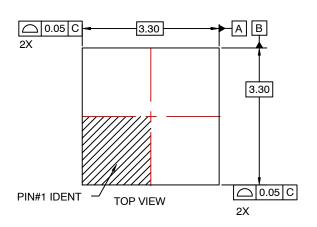
| Device | Device Marking | Package Type | Shipping [†] |
|------------|----------------|---|-----------------------|
| FDMC6679AZ | FDMC6679AZ | WDFN8 3.3x3.3, 0.65P, Case 511DH (Pb-Free) | 3000 / Tape & Reel |

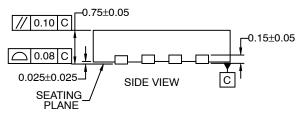
[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

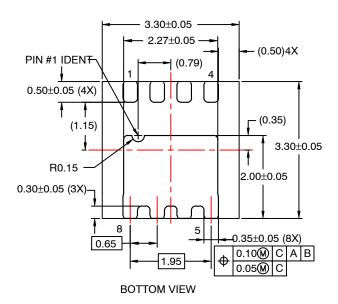
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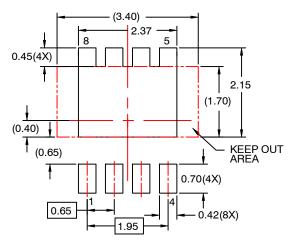
WDFN8 3.3x3.3, 0.65P CASE 511DH ISSUE O

DATE 31 JUL 2016









RECOMMENDED LAND PATTERN

NOTES:

- A. DOES NOT CONFORM TO JEDEC REGISTRATION MO-229
- B. DIMENSIONS ARE IN MILLIMETERS.
- C. DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 2009.
- D. LAND PATTERN RECOMMENDATION IS EXISTING INDUSTRY LAND PATTERN.

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